Notice of References Cited

Application/Control No.

O9/872,647

Examiner

Satish S. Rampuria

Applicant(s)/Patent Under Reexamination SRIVASTAVA ET AL.

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,708,173 B1	03-2004	Behr et al.	707/10
	В	US-5,708,825	01-1998	Sotomayor, Bernardo Rafael	715/501.1
	С	US-6,738,778 B1	05-2004	Williamson et al.	707/101
	D	US-6,282,701 B1	08-2001	Wygodny et al.	717/125
	Ε	US-2002/0107882 A1	08-2002	Gorelick et al.	707/500.1
	F	US-2002/0004803	01-2002	Serebrennikov, Oleg	707/513
	G	US-2002/0066081 A1	05-2002	Duesterwald et al.	717/128
	Н	US-6,738,965 B1	05-2004	Webster, Matthew Alexander	717/128
	ı	US-5,920,719 A	07-1999	Sutton et al.	717/130
	J	US-6,715,140 B1	03-2004	Haga, Yutaka	717/130
	к	US-6,574,792 B1	06-2003	Easton, John Paul	717/142
	L	US-6,353,924 B1	03-2002	Ayers et al.	717/128
	М	US-2002/0095660 A1	07-2002	O'Brien et al.	717/127

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Helmbold et al., Detecting data races from sequential traces, 1991, IEEE, pg. 408-417
	٧	Tolujev et al., Assessment of simulation models based on traces-file analysis: A metamodeling approach, 1998, IEEE, vol. 1, pg. 443-450
	w	Helmbold et al., Determining possible event orders by analysing sequential traces, IEEE, vol. 4, pg. 827-840
	×	Palnitkar et al., Finite state machine trace analysis program, 1994, IEEE, pg. 52-57

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

...uce of References Cited

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Application/Control No. 09/872,647		Applicant(s)/Patent Under Reexamination SRIVASTAVA ET AL.		
	Examiner	Art Unit		
	Satish S. Rampuria	2124	Page 2 of 2	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0019837	02-2002	Balnaves, James A.	707/512
	В	US-5,649,085	07-1997	Lehr, Theodore Franklin	345/440
	С	US-6,026,362 A	02-2000	Kim et al.	705/1
	D	US-6,470,349 B1	10-2002	Heninger et al.	707/102
	E	US-2003/0140045 A1	07-2003	Heninger et al.	707/10
	F	US-2002/0078143 A1	06-2002	De Boor et al.	709/203
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.